Search Notes



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Application/Control No.

Applicant(s)/Patent under Reexamination

10/511,649

VIEBAHN ET AL.

Examiner

Art Unit

3661

CUONG H. NGUYEN

SEARCHED						
Class	Subclass	Date	Examiner			
701	3,11,14	10/12/2007	СНИ			
	301-302					
340	961,963					
V	964	V	1			

INTERFERENCE SEARCHED					
Class	Subclass	Date		Examiner	
701	3	10/13/2007		CHN	
340	961,963		,		`
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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US PGPUBS				
IEEE Xplore				
Inventors'names seardch	V			
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